

## MOSFET

### 650 V CoolSiC™ M1 SiC Trench Power Device

The 650 V CoolSiC™ is built over the solid silicon carbide technology developed in Infineon in more than 20 years. Leveraging the wide bandgap SiC material characteristics, the 650V CoolSiC™ MOSFET offers a unique combination of performance, reliability and ease of use. Suitable for high temperature and harsh operations, it enables the simplified and cost effective deployment of the highest system efficiency.

#### Features

- Optimized switching behavior at higher currents
- Commutation robust fast body diode with low  $Q_f$
- Superior gate oxide reliability
- $T_{j,max}=175^{\circ}\text{C}$  and excellent thermal behavior
- Lower  $R_{DS(on)}$  and pulse current dependency on temperature
- Increased avalanche capability
- Compatible with standard drivers (recommended driving voltage: 0V-18V)
- Kelvin source provides up to 4 times lower switching losses

#### Benefits

- Unique combination of high performance, high reliability and ease of use
- Ease of use and integration
- Suitable for topologies with continuous hard commutation
- Higher robustness and system reliability
- Efficiency improvement
- Reduced system size leading to higher power density

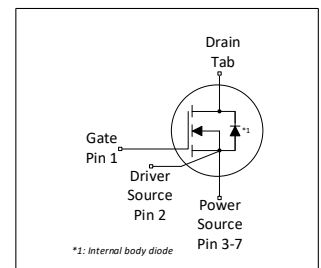
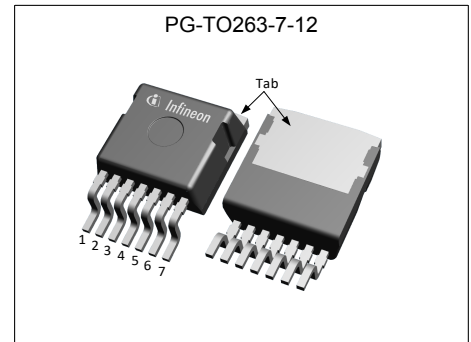
#### Potential applications

- Telecom and Server SMPS
- UPS (uninterruptable power supplies)
- Solar PV inverters
- EV charging infrastructure
- Energy storage and battery formation
- Class D amplifiers

#### Product validation

Fully qualified according to JEDEC for Industrial Applications

*Please note: The source and sense source pins are not exchangeable. Their exchange might lead to malfunction.*



RoHS

**Table 1 Key Performance Parameters**

| Parameter                           | Value | Unit             |
|-------------------------------------|-------|------------------|
| $V_{DS} @ T_J = 25^{\circ}\text{C}$ | 650   | V                |
| $R_{DS(on),typ}$                    | 48    | $\text{m}\Omega$ |
| $R_{DS(on),max}$                    | 64    | $\text{m}\Omega$ |
| $Q_{G,typ}$                         | 33    | nC               |
| $I_{DM}$                            | 99    | A                |
| $Q_{oss} @ 400 \text{ V}$           | 78    | nC               |
| $E_{oss} @ 400 \text{ V}$           | 11.7  | $\mu\text{J}$    |

| Type / Ordering Code | Package       | Marking  | Related Links  |
|----------------------|---------------|----------|----------------|
| IMBG65R048M1H        | PG-TO263-7-12 | 65R048M1 | see Appendix A |

**Table of Contents**

Description ..... 1

Maximum ratings ..... 3

Thermal characteristics ..... 4

Operating range ..... 4

Electrical characteristics ..... 5

Electrical characteristics diagrams ..... 7

Test Circuits ..... 12

Package Outlines ..... 13

Appendix A ..... 14

Revision History ..... 15

Trademarks ..... 15

Disclaimer ..... 15

## 1 Maximum ratings

at  $T_J = 25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                                           | Symbol    | Values |      |          | Unit | Note / Test Condition                                                                     |
|-----------------------------------------------------|-----------|--------|------|----------|------|-------------------------------------------------------------------------------------------|
|                                                     |           | Min.   | Typ. | Max.     |      |                                                                                           |
| Continuous DC drain current <sup>1)</sup>           | $I_D$     | -      | -    | 45<br>32 | A    | $T_C = 25\text{ °C}$<br>$T_C = 100\text{ °C}$                                             |
| Peak drain current <sup>2)</sup>                    | $I_{DM}$  | -      | -    | 99       | A    | $T_C = 25\text{ °C}$                                                                      |
| Avalanche energy, single pulse                      | $E_{AS}$  | -      | -    | 171      | mJ   | $I_D = 6.4\text{ A}$ , $V_{DD} = 50\text{ V}$ ; see table 11                              |
| Avalanche energy, repetitive                        | $E_{AR}$  | -      | -    | 0.85     | mJ   | $I_D = 6.4\text{ A}$ , $V_{DD} = 50\text{ V}$ ; see table 11                              |
| Avalanche current, single pulse                     | $I_{AS}$  | -      | -    | 6.4      | A    | -                                                                                         |
| MOSFET $dv/dt$ ruggedness                           | $dv/dt$   | -      | -    | 200      | V/ns | $V_{DS} = 0\ldots 400\text{ V}$                                                           |
| Gate source voltage (static) <sup>3)</sup>          | $V_{GS}$  | -5     | -    | 23       | V    | static                                                                                    |
| Gate source voltage (transient)                     | $V_{GS}$  | -7     | -    | 25       | V    | $t_{pulse, positive} \leq 1\%$ duty cycle/ $f_{sw}$                                       |
| Power dissipation                                   | $P_{tot}$ | -      | -    | 183      | W    | $T_C = 25\text{ °C}$                                                                      |
| Storage temperature                                 | $T_{stg}$ | -55    | -    | 150      | °C   | -                                                                                         |
| Operating junction temperature                      | $T_J$     | -55    | -    | 175      | °C   | -                                                                                         |
| Mounting torque                                     | -         | -      | -    | n.a.     | Ncm  | -                                                                                         |
| Continuous reverse drain current <sup>1)</sup>      | $I_{SDC}$ | -      | -    | 45<br>30 | A    | $V_{GS}=18\text{ V}$ , $T_C = 25\text{ °C}$<br>$V_{GS}=0\text{ V}$ , $T_C = 25\text{ °C}$ |
| Repetitive peak reverse drain current <sup>1)</sup> | $I_{SRM}$ | -      | -    | 99       | A    | $T_C = 25\text{ °C}$ , pulse width $t_p \leq 250\text{ ns}$                               |
| Insulation withstand voltage                        | $V_{ISO}$ | -      | -    | n.a.     | V    | $V_{rms}$ , $T_C = 25\text{ °C}$ , $t = 1\text{ min}$                                     |

<sup>1)</sup> Limited by  $T_{J,max}$

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{J,max}$

<sup>3)</sup> The maximum gate-source voltage in the application design should be in accordance to IPC-9592B

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                               | Symbol     | Values |      |      | Unit | Note / Test Condition                                                                                                                                                               |
|---------------------------------------------------------|------------|--------|------|------|------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                                         |            | Min.   | Typ. | Max. |      |                                                                                                                                                                                     |
| Thermal resistance, junction - case                     | $R_{thJC}$ | -      | -    | 0.82 | °C/W | -                                                                                                                                                                                   |
| Thermal resistance, junction - ambient                  | $R_{thJA}$ | -      | -    | 62   | °C/W | device on PCB, minimal footprint                                                                                                                                                    |
| Thermal resistance, junction - ambient for SMD version  | $R_{thJA}$ | -      | 35   | 45   | °C/W | Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm <sup>2</sup> (one layer, 70µm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling. |
| Soldering temperature, wave- & reflow soldering allowed | $T_{sold}$ | -      | -    | 260  | °C   | reflow MSL1                                                                                                                                                                         |

## 3 Operating range

**Table 4 Operating range**

| Parameter                                                               | Symbol   | Values |      |      | Unit | Note / Test Condition |
|-------------------------------------------------------------------------|----------|--------|------|------|------|-----------------------|
|                                                                         |          | Min.   | Typ. | Max. |      |                       |
| Gate-source voltage operating range including undershoots <sup>1)</sup> | $V_{GS}$ | -2     | -    | 20   | V    | -                     |

<sup>1)</sup> **Important note: the selection of positive and negative gate-source voltages impacts the long-term behavior of the device.** The design guidelines described in the CoolSiC™ MOSFET 650 V M1 trench power device application note AN\_1907\_PL52\_1911\_144109 must be considered to ensure sound operation of the device over the planned lifetime.

## 4 Electrical characteristics

at  $T_J = 25\text{ °C}$ , unless otherwise specified

**Table 5 Static characteristics**

| Parameter                            | Symbol        | Values |                |            | Unit | Note / Test Condition                                                                                                                             |
|--------------------------------------|---------------|--------|----------------|------------|------|---------------------------------------------------------------------------------------------------------------------------------------------------|
|                                      |               | Min.   | Typ.           | Max.       |      |                                                                                                                                                   |
| Drain-source breakdown voltage       | $V_{(BR)DSS}$ | 650    | -              | -          | V    | $V_{GS} = 0\text{ V}$ , $I_D = 0.6\text{ mA}$                                                                                                     |
| Gate threshold voltage <sup>1)</sup> | $V_{GS(th)}$  | 3.5    | 4.5            | 5.7        | V    | $V_{DS} = V_{GS}$ , $I_D = 6\text{ mA}$                                                                                                           |
| Zero gate voltage drain current      | $I_{DSS}$     | -      | 1<br>3         | 150<br>-   | μA   | $V_{DS} = 650\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 25\text{ °C}$<br>$V_{DS} = 650\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 175\text{ °C}$ |
| Gate leakage current                 | $I_{GSS}$     | -      | -              | 100        | nA   | $V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$                                                                                                    |
| Drain-source on-state resistance     | $R_{DS(on)}$  | -      | 0.048<br>0.067 | 0.064<br>- | Ω    | $V_{GS} = 18\text{ V}$ , $I_D = 20.1\text{ A}$ , $T_J = 25\text{ °C}$<br>$V_{GS} = 18\text{ V}$ , $I_D = 20.1\text{ A}$ , $T_J = 175\text{ °C}$   |
| Internal gate resistance             | $R_G$         | -      | 6.0            | -          | Ω    | $f = 1\text{ MHz}$                                                                                                                                |

**Table 6 Dynamic characteristics**

| Parameter                                                  | Symbol       | Values |      |      | Unit | Note / Test Condition                                                                                             |
|------------------------------------------------------------|--------------|--------|------|------|------|-------------------------------------------------------------------------------------------------------------------|
|                                                            |              | Min.   | Typ. | Max. |      |                                                                                                                   |
| Input capacitance                                          | $C_{iss}$    | -      | 1118 | -    | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$                                            |
| Reverse transfer capacitance                               | $C_{riss}$   | -      | 13   | -    | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$                                            |
| Output capacitance <sup>2)</sup>                           | $C_{oss}$    | -      | 129  | 168  | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$                                            |
| Output charge <sup>2)</sup>                                | $Q_{oss}$    | -      | 78   | 101  | nC   | calculation based on $C_{oss}$                                                                                    |
| Effective output capacitance, energy related <sup>3)</sup> | $C_{o(er)}$  | -      | 146  | -    | pF   | $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = 0...400\text{ V}$                                                            |
| Effective output capacitance, time related <sup>4)</sup>   | $C_{o(tr)}$  | -      | 194  | -    | pF   | $I_D = \text{constant}$ , $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = 0...400\text{ V}$                                  |
| Turn-on delay time                                         | $t_{d(on)}$  | -      | 6.7  | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 20.1\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 10 |
| Rise time                                                  | $t_r$        | -      | 9.6  | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 20.1\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 10 |
| Turn-off delay time                                        | $t_{d(off)}$ | -      | 15.2 | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 20.1\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 10 |
| Fall time                                                  | $t_f$        | -      | 7    | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 20.1\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 10 |

<sup>1)</sup> Tested after 1 ms pulse at  $V_{GS} = +20\text{ V}$

<sup>2)</sup> Maximum specification is defined by calculated six sigma upper confidence bound

<sup>3)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V

<sup>4)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V

**Table 7 Gate charge characteristics**

| Parameter             | Symbol   | Values |      |      | Unit | Note / Test Condition                                                                   |
|-----------------------|----------|--------|------|------|------|-----------------------------------------------------------------------------------------|
|                       |          | Min.   | Typ. | Max. |      |                                                                                         |
| Gate to source charge | $Q_{gs}$ | -      | 9    | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_D = 20.1\text{ A}$ ,<br>$V_{GS} = 0\text{ to }18\text{ V}$ |
| Gate to drain charge  | $Q_{gd}$ | -      | 7    | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_D = 20.1\text{ A}$ ,<br>$V_{GS} = 0\text{ to }18\text{ V}$ |
| Gate charge total     | $Q_g$    | -      | 33   | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_D = 20.1\text{ A}$ ,<br>$V_{GS} = 0\text{ to }18\text{ V}$ |

**Table 8 Body diode characteristics**

| Parameter                            | Symbol    | Values |      |      | Unit | Note / Test Condition                                                                                       |
|--------------------------------------|-----------|--------|------|------|------|-------------------------------------------------------------------------------------------------------------|
|                                      |           | Min.   | Typ. | Max. |      |                                                                                                             |
| Drain-source reverse voltage         | $V_{SD}$  | -      | 4.0  | -    | V    | $V_{GS} = 0\text{ V}$ , $I_S = 20.1\text{ A}$ , $T_J = 25\text{ °C}$                                        |
| MOSFET forward recovery time         | $t_{fr}$  | -      | 20.1 | -    | ns   | $V_{DD} = 400\text{ V}$ , $I_{S0} = 20.1\text{ A}$ ,<br>$di_S/dt = 1000\text{ A}/\mu\text{s}$ ; see table 9 |
| MOSFET forward recovery charge       | $Q_f$     | -      | 82   | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_{S0} = 20.1\text{ A}$ ,<br>$di_S/dt = 1000\text{ A}/\mu\text{s}$ ; see table 9 |
| MOSFET peak forward recovery current | $I_{frm}$ | -      | 7.4  | -    | A    | $V_{DD} = 400\text{ V}$ , $I_{S0} = 20.1\text{ A}$ ,<br>$di_S/dt = 1000\text{ A}/\mu\text{s}$ ; see table 9 |

## 5 Electrical characteristics diagrams

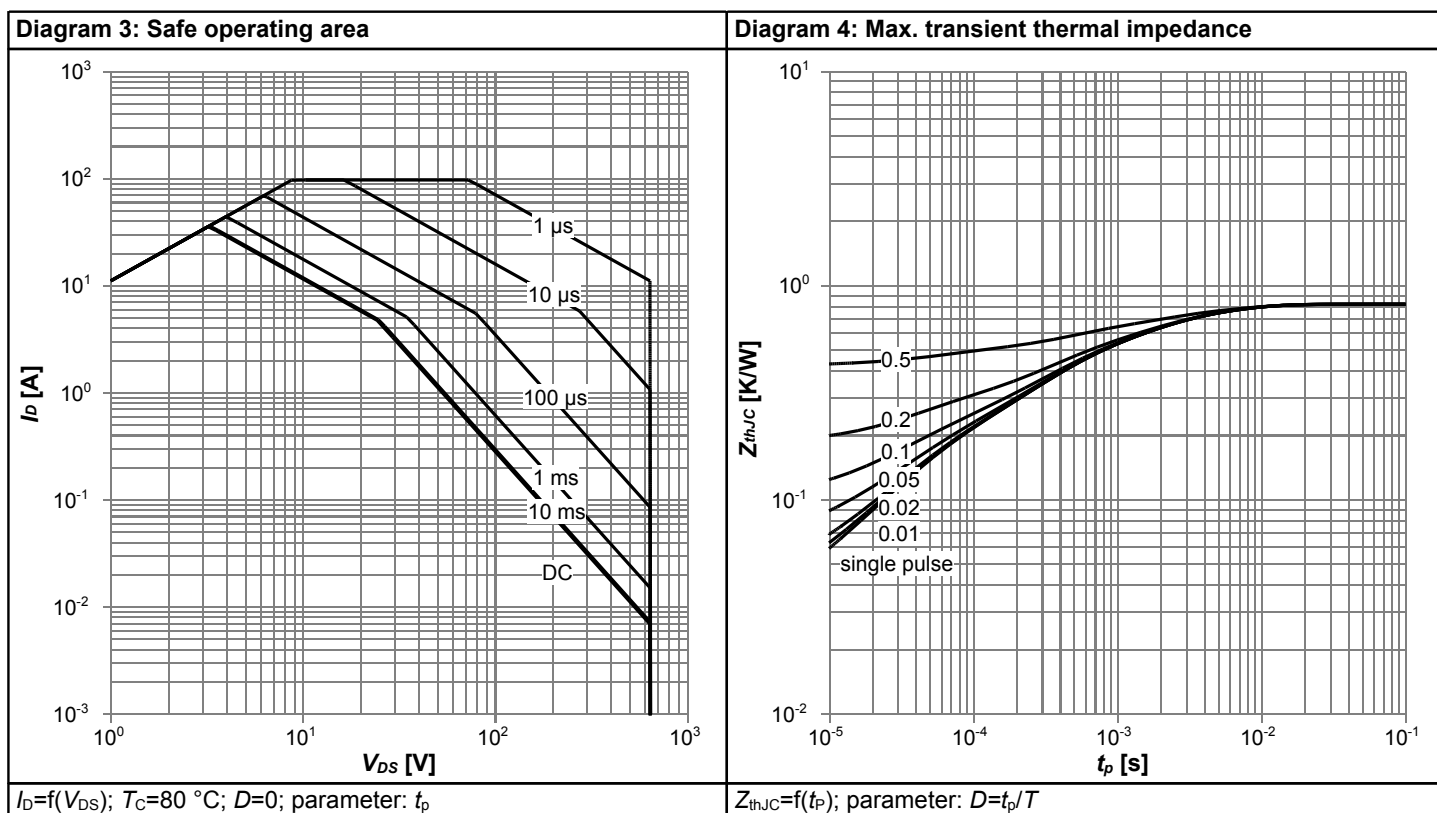
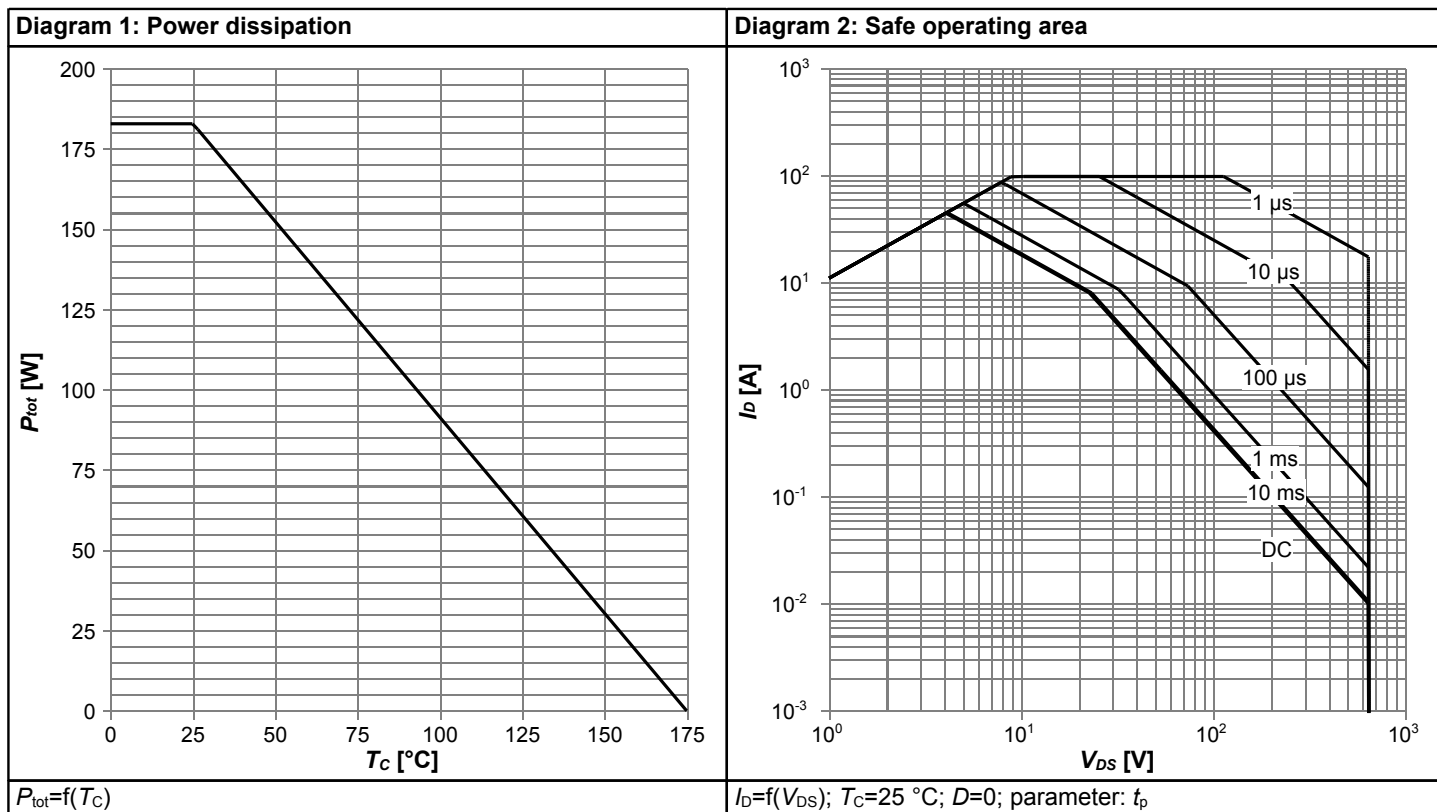
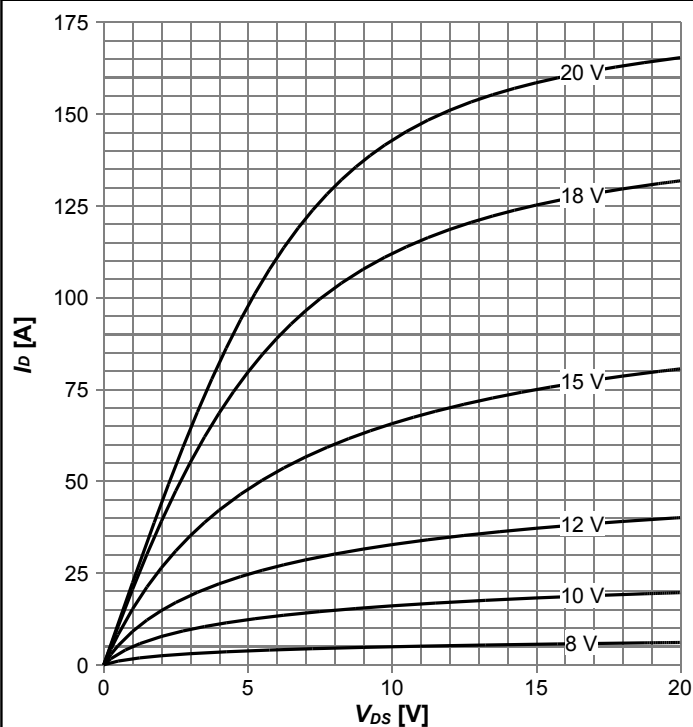
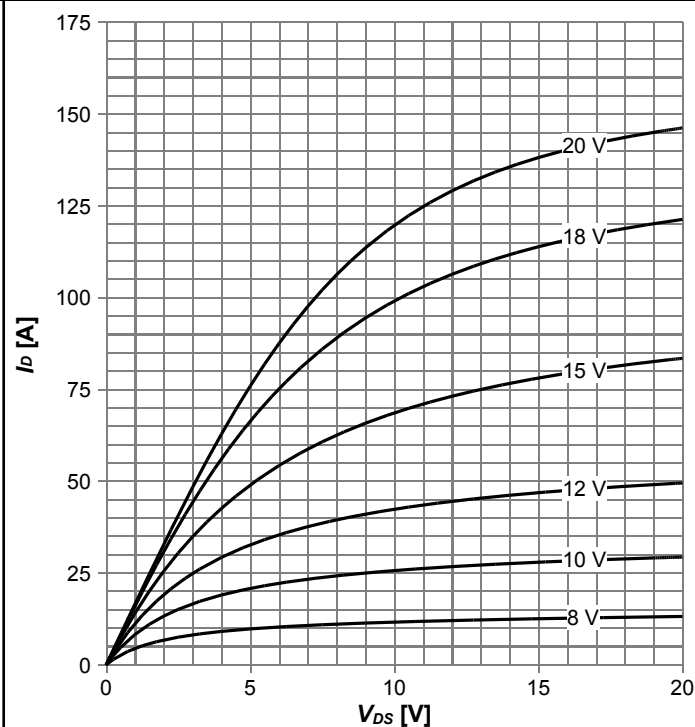


Diagram 5: Typ. output characteristics



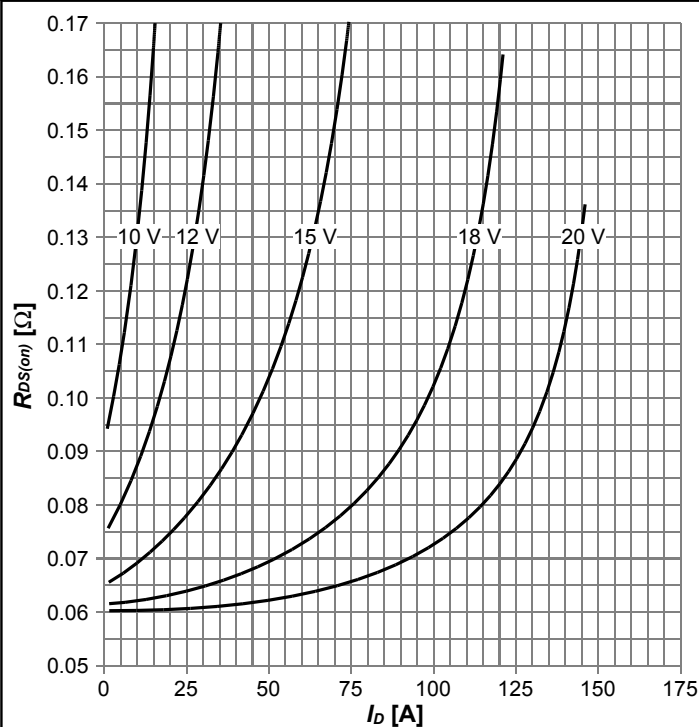
$I_D = f(V_{DS})$ ;  $T_j = 25\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. output characteristics



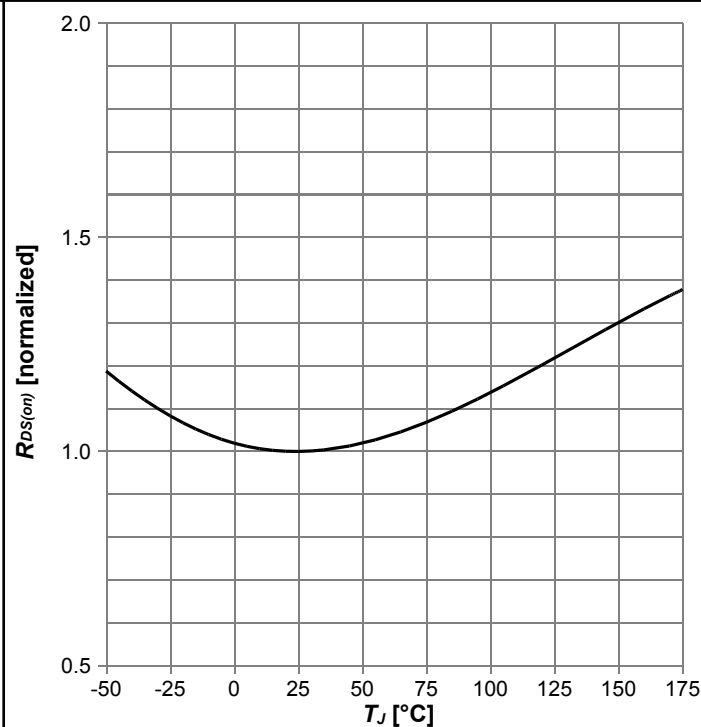
$I_D = f(V_{DS})$ ;  $T_j = 150\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. drain-source on-state resistance



$R_{DS(on)} = f(I_D)$ ;  $T_j = 150\text{ °C}$ ; parameter:  $V_{GS}$

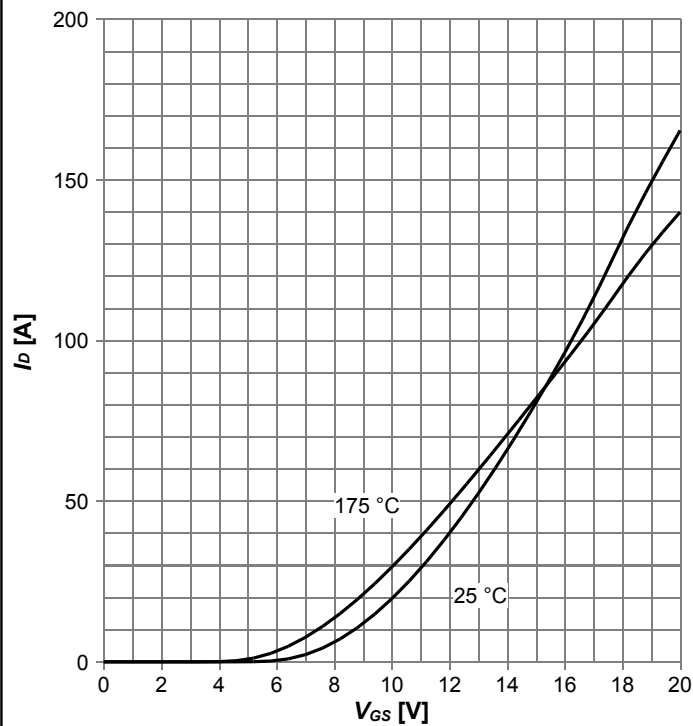
Diagram 8: Drain-source on-state resistance



$R_{DS(on)} = f(T_j)$ ;  $I_D = 20.1\text{ A}$ ;  $V_{GS} = 18\text{ V}$

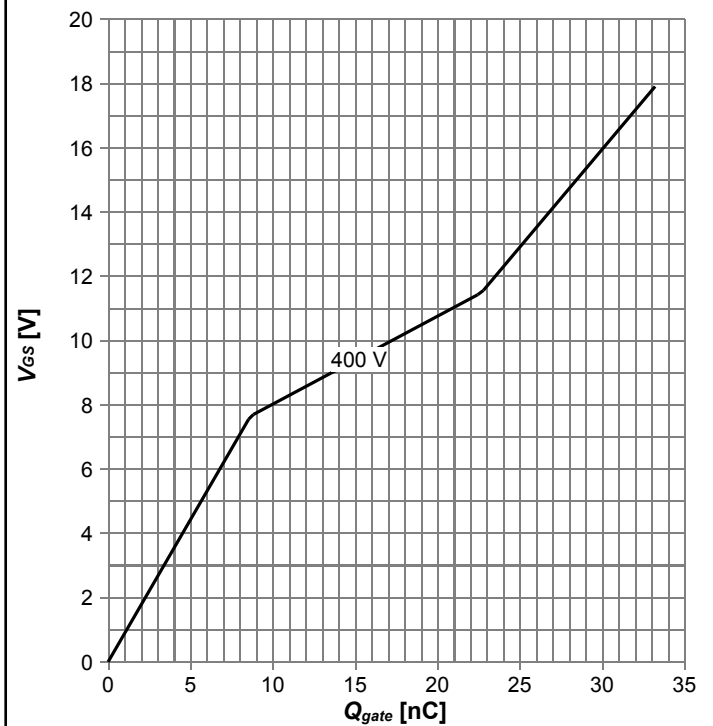


Diagram 9: Typ. transfer characteristics



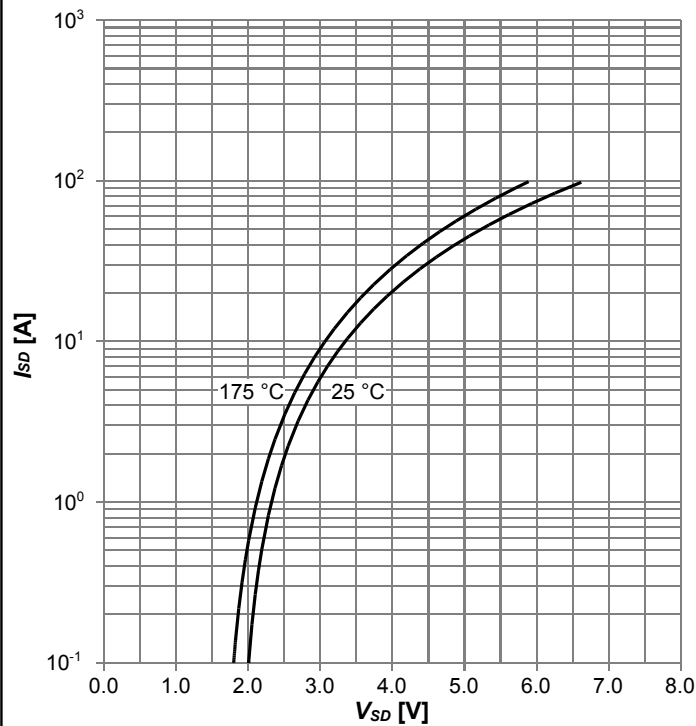
$I_D = f(V_{GS})$ ;  $V_{DS} = 20V$ ; parameter:  $T_j$

Diagram 10: Typ. gate charge



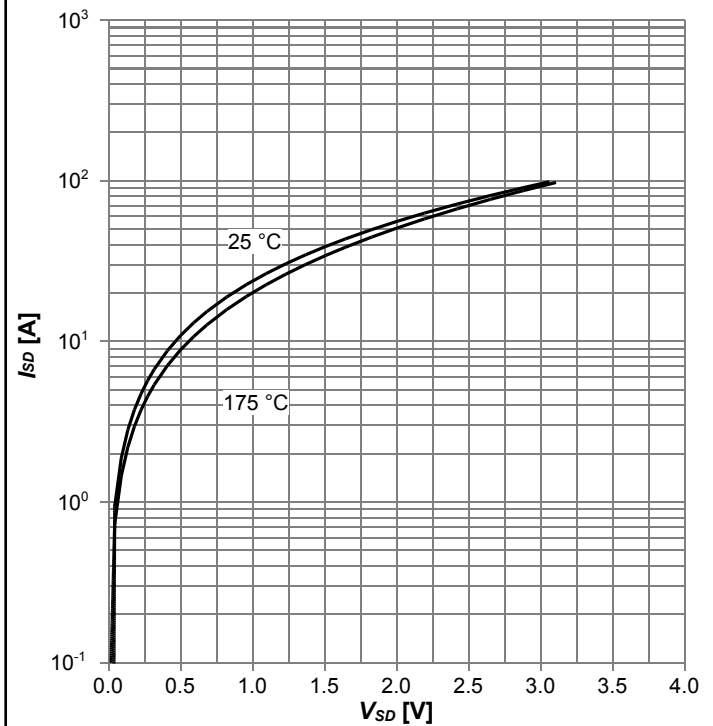
$V_{GS} = f(Q_{gate})$ ;  $I_D = 20.1 A$  pulsed; parameter:  $V_{DD}$

Diagram 11: Typ. reverse characteristics



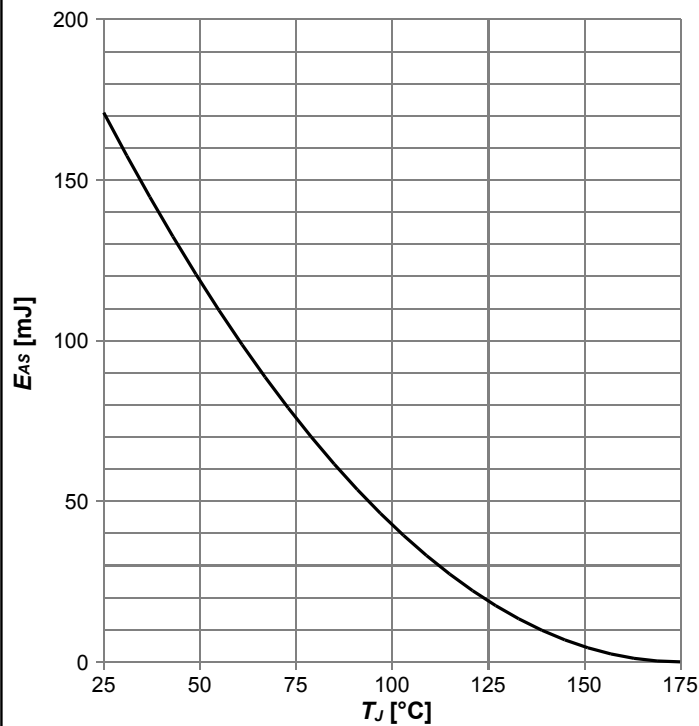
$I_{SD} = f(V_{SD})$ ;  $V_{GS} = 0 V$ ; parameter:  $T_j$

Diagram 12: Typ. reverse characteristics



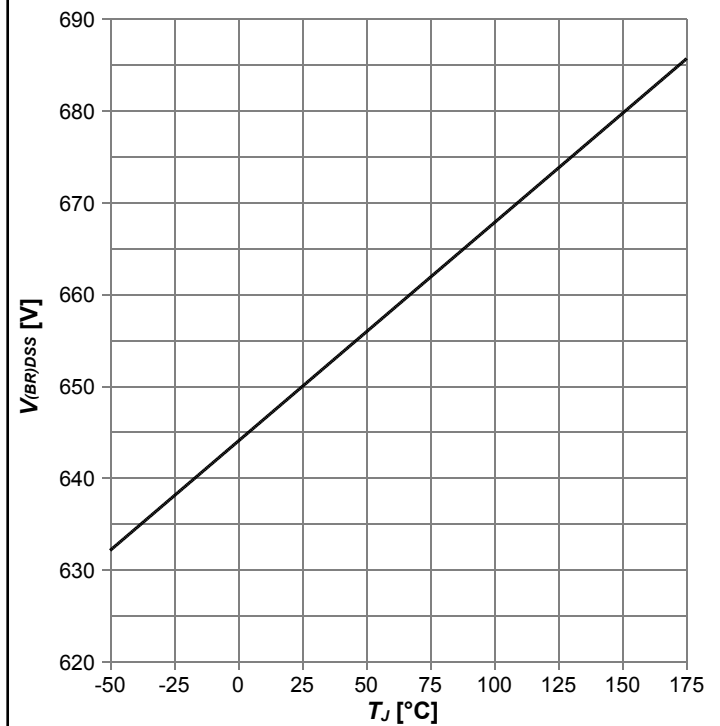
$I_{SD} = f(V_{SD})$ ;  $V_{GS} = 18 V$ ; parameter:  $T_j$

Diagram 13: Avalanche energy



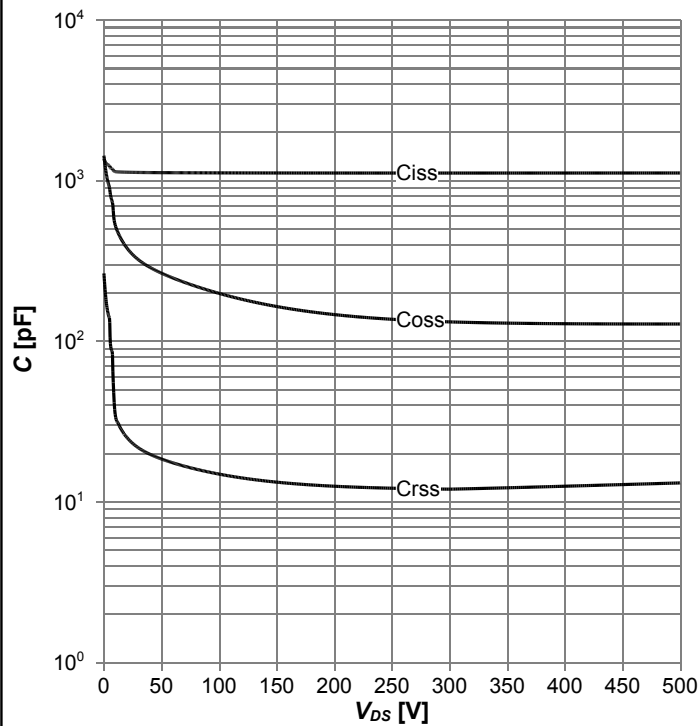
$E_{AS}=f(T_J)$ ;  $I_D=6.4$  A;  $V_{DD}=50$  V

Diagram 14: Drain-source breakdown voltage



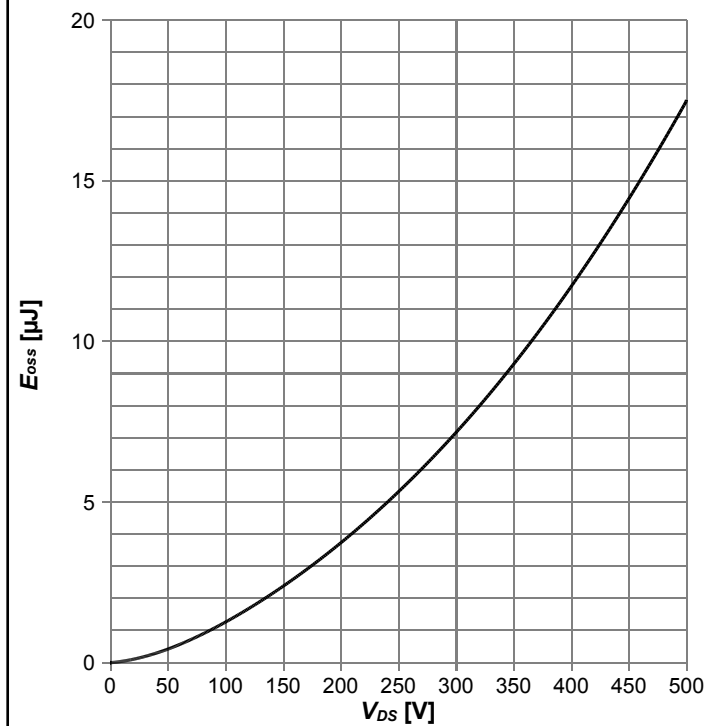
$V_{(BR)DSS}=f(T_J)$ ;  $I_D=0.6$  mA

Diagram 15: Typ. capacitances



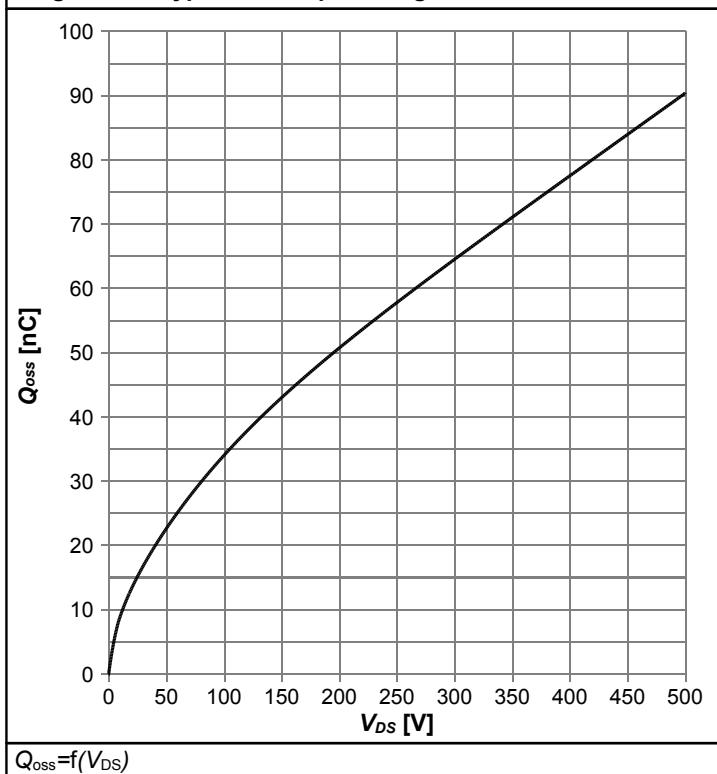
$C=f(V_{DS})$ ;  $V_{GS}=0$  V;  $f=250$  kHz

Diagram 16: Typ. Coss stored energy



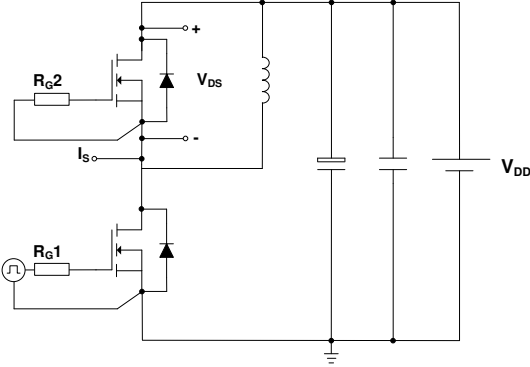
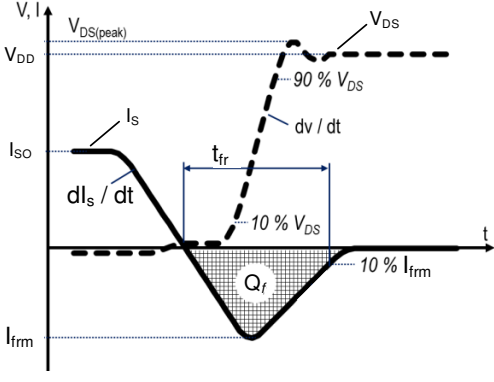
$E_{oss}=f(V_{DS})$

Diagram 17: Typ. Qoss output charge

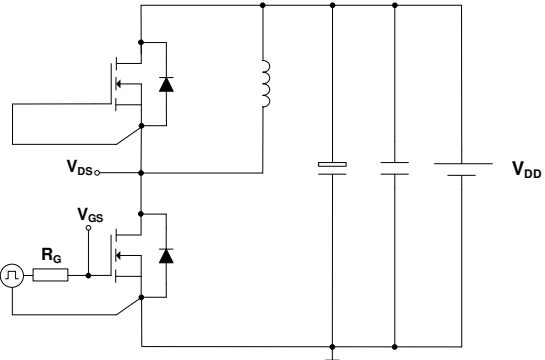
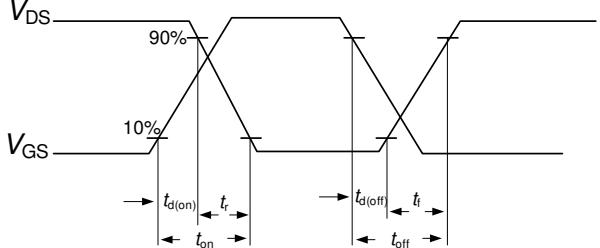


## 6 Test Circuits

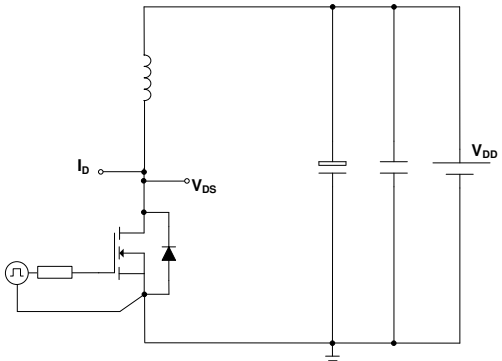
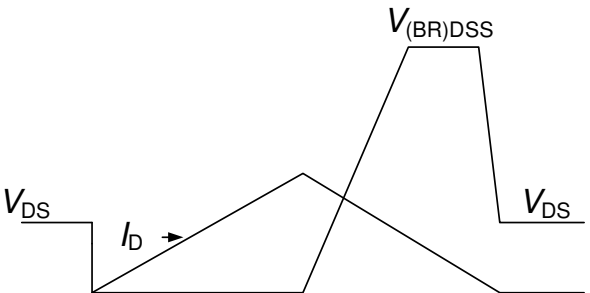
**Table 9 Body diode characteristics (650V CoolSiC)**

| Test circuit for body diode characteristics                                       | Body diode recovery waveform                                                       |
|-----------------------------------------------------------------------------------|------------------------------------------------------------------------------------|
|  |  |

**Table 10 Switching times (650V CoolSiC)**

| Switching times test circuit for inductive load                                     | Switching times waveform                                                             |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |

**Table 11 Unclamped inductive load (650V CoolSiC)**

| Unclamped inductive load test circuit                                               | Unclamped inductive waveform                                                         |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |

## 7 Package Outlines

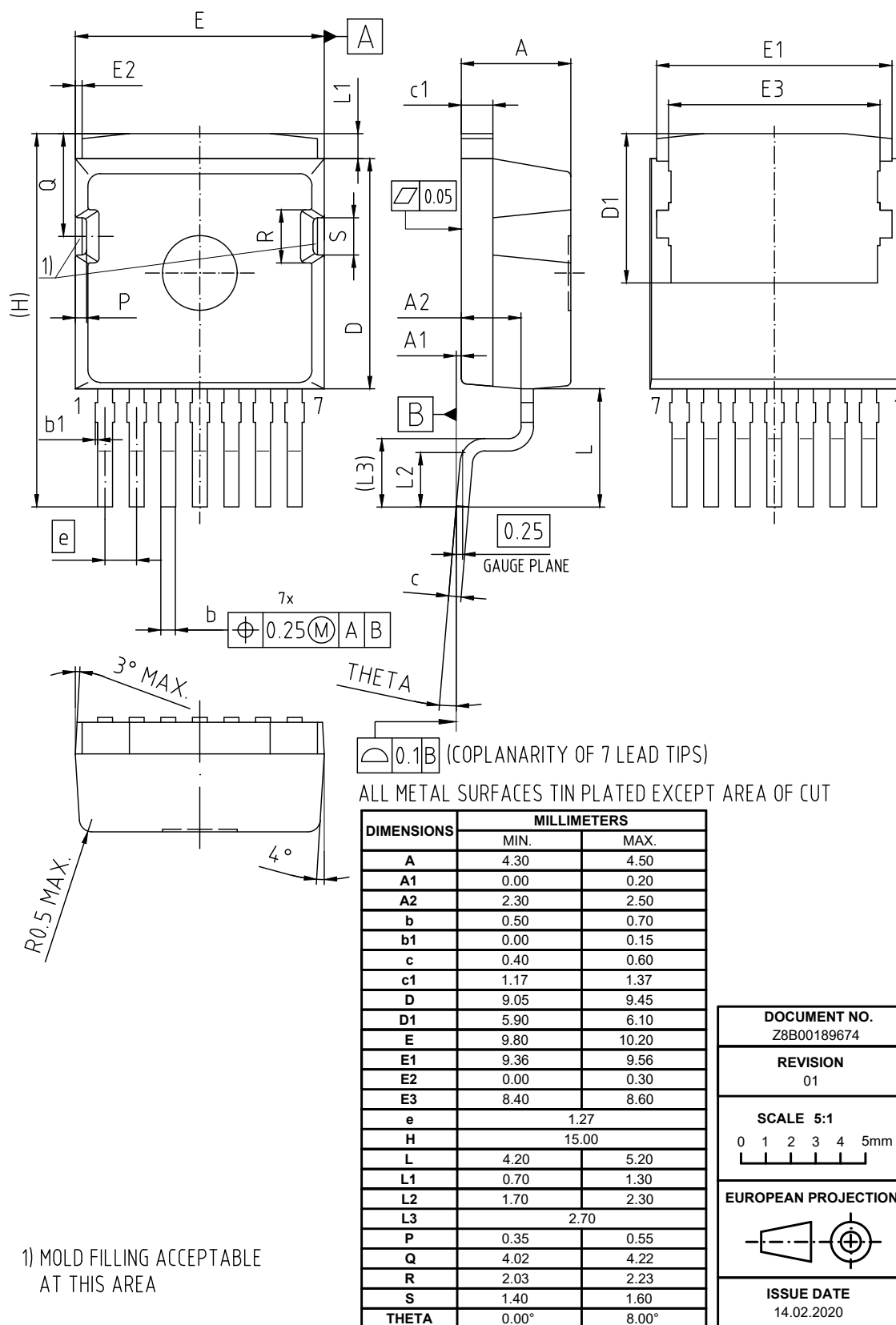


Figure 1 Outline PG-TO263-7-12, dimensions in mm

## **8 Appendix A**

**Table 12 Related Links**

- **IFX CoolSiC M1 Webpage:** [www.infineon.com](http://www.infineon.com)
- **IFX CoolSiC M1 application note:** [www.infineon.com](http://www.infineon.com)
- **IFX CoolSiC M1 simulation model:** [www.infineon.com](http://www.infineon.com)
- **IFX Design tools:** [www.infineon.com](http://www.infineon.com)

## Revision History

IMBG65R048M1H

**Revision: 2021-12-10, Rev. 2.0**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.0      | 2021-12-10 | Release of final version                     |

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